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Substitute Form PTO-1449 (Mosified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 08774-269US1	Application No. 10/519,032	
1	closure Statement pplicant	Applicant Fatiha Anouar et al.		
(Use several s	heets if necessary)	Filing Date December 22, 2004	Group Art Unit 2624	

	U.S. Patent Documents								
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate		
/M.T./	AA	6,163,618	12/19/2000	Mukai					
	AB								
	AC								
	AD								
	AE								
	AF			·					

Foreign Patent Documents or Published Foreign Patent Applications								
Examiner	Desig.	Document	Publication	Country or			Trans	slation
Initial	ID	Number	Date	Patent Office	Class	Subclass	Yes	No
/M.T./	AG	WO 03/061981 A1	7/31/2003	WIPO			х	
	AH	2003-246134	9/2/2003	Japan			x	
	AI	2003-200647	7/15/2003	Japan			х	
V	AJ	WO 94/12951	6/9/1994	WIPO				
	AK							

	Other Documents (include Author, Title, Date, and Place of Publication)						
Examiner Initial	Desig. ID	Document					
/M.T./	AL	Meijering et al., "Quantitative Comparison of Sinc-Approximating Kernels for Medical Image Interpolation," Lecture Notes in Computer Science 1679: 210-217, 1999, XP002227048					
/M.T./	AM	Wolberg, "Image Resampling," IEEE Computer Society Press, Los Alamitos, CA, XP002227049, pages 117-149 & pages 160-161, January 29, 2003.					
	AN						
	AO	-					

Examiner Signature /Mia Thomas/	Date Considered 11/26/2007					
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Substitute Disclosure Form (PTO-1449)

Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 08774-269US1	Application No. 10/519,032	
	closure Statement pplicant	Applicant Fatiha Anouar et al.		
(Use several si	heets if necessary)	Filing Date August 9, 2005	Group Art Unit 2624	

	U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate	
	AA							
	AB							
	AC							
	AD							
	AE							
	AF							
	AG	-						
	AH							
	AI							
	AJ							
	AK							

	Foreign Patent Documents or Published Foreign Patent Applications							
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass		lation No
/M.T./	AL	EP0671040	9/13/1995	Europe				
	AM							
	AN							
	AO							
	AP							

	Other Do	ocuments (include Author, Title, Date, and Place of Publication)
Examiner Initial	Desig. ID	Document
	AQ	
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	AS	
	AT	

Examiner Signature	/Mia Thomas/	Date Considered	11/26/2007			
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